

BSZ900N20NS3 G-VB Datasheet

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY

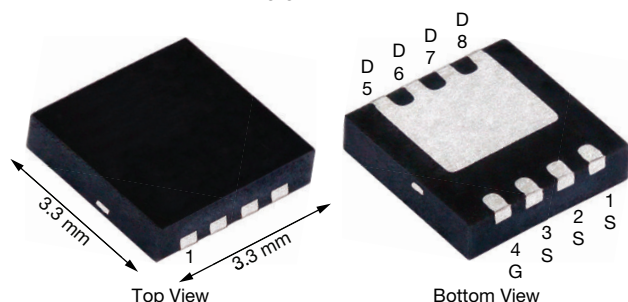
V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^a	Q_g (TYP.)
200	0.085 at $V_{GS} = 10$ V	14.1	9.3 nC
	0.089 at $V_{GS} = 7.5$ V	13.8	

FEATURES

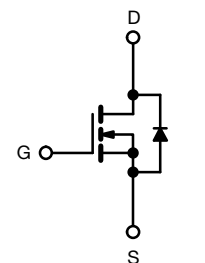
- Thunder power MOSFET
- Optimized Q_g and Q_{oss} improve efficiency
- 100 % R_g and UIS tested


RoHS
 COMPLIANT
 HALOGEN
FREE

DFN 3x3 EP

**APPLICATIONS**

- Primary side switching
- Synchronous rectification
- DC/DC converters
- Boost converters



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V_{DS}	200	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 150$ °C)	$T_C = 25$ °C	I_D	14.1	A
	$T_C = 70$ °C		11.2	
	$T_A = 25$ °C		4.1 ^{b, c}	
	$T_A = 70$ °C		3.2 ^{b, c}	
Pulsed Drain Current ($t = 100$ μ s)		I_{DM}	30	
Continuous Source-Drain Diode Current	$T_C = 25$ °C	I_S	14.1	A
	$T_A = 25$ °C		4.3 ^{b, c}	
Single Pulse Avalanche Current	$L = 0.1$ mH	I_{AS}	10	mJ
Single Pulse Avalanche Energy		E_{AS}	5	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	57	W
	$T_C = 70$ °C		36	
	$T_A = 25$ °C		4.8 ^{b, c}	
	$T_A = 70$ °C		3 ^{b, c}	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature) ^{d, e}			260	

THERMAL RESISTANCE RATINGS

PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum Junction-to-Ambient ^{b, f}	$t \leq 10$ s	R_{thJA}	21	26	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	1.7	2.2	

Notes

- Based on $T_C = 25$ °C.
- Surface mounted on 1" x 1" FR4 board.
- $t = 10$ s.
- The DFN3x3 package is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under steady state conditions is 70 °C/W.

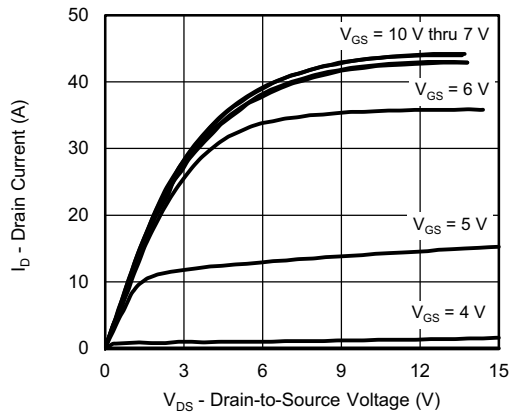
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	200	-	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA	-	186	-	mV/°C	
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J		-	-6	-		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2	-	4	V	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V	-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	μA	
		V = 200 V, V _{DS GS} = 0 V, T _J = 70 °C	-	-	10		
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	15	-	-	A	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 7 A	-	0.085	-	Ω	
		V _{GS} = 7.5 V, I _D = 7 A	-	0.089	-		
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 7 A	-	16.5	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}	V _{DS} = 100 V, V _{GS} = 0 V, f = 1 MHz	-	608	-	pF	
Output Capacitance	C _{oss}		-	57	-		
Reverse Transfer Capacitance	C _{rss}		-	7	-		
Total Gate Charge	Q _g	V = 100 V, V _{GS} = 10 V, I _D = 3 A	-	12.1	18.2	nC	
		V _{DS} = 100 V, V _{GS} = 7.5 V, I _D = 3 A	-	9.3	14		
Q _{gs}	-		2.9	-			
Q _{gd}	-		2.9	-			
Q _{oss}	-	19.5	-				
Gate Resistance	R _g	V _{DS} = 100 V, V _{GS} = 0 V	-	19.5	-	Ω	
Turn-On Delay Time	t _{d(on)}	f = 1 MHz	0.6	1.9	3.5	ns	
Rise Time	t _r		V _{DD} = 100 V, R _L = 33.3 Ω I _D ≅ 3 A, V _{GEN} = 10 V, R _g = 1 Ω	-	8		16
Turn-Off Delay Time	t _{d(off)}			-	16		32
Fall Time	t _f			-	16		32
Turn-On Delay Time	t _{d(on)}	V _{DD} = 100 V, R _L = 33.3 Ω I _D ≅ 3 A, V _{GEN} = 7.5 V, R _g = 1 Ω		-	10		20
Rise Time	t _r		-	17	34		
Turn-Off Delay Time	t _{d(off)}		-	14	28		
Fall Time	t _f		-	16	32		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	14.1	A	
Pulse Diode Forward Current (t = 100 μs)	I _{SM}		-	-	30		
Body Diode Voltage	V _{SD}	I _S = 5 A	-	0.82	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}	I _F = 5 A, dI/dt = 100 A/μs, T _J = 25 °C	-	89	178	ns	
Body Diode Reverse Recovery Charge	Q _{rr}		-	258	516	nC	
Reverse Recovery Fall Time	t _a		-	72	-	ns	
Reverse Recovery Rise Time	t _b		-	17	-		

Notes

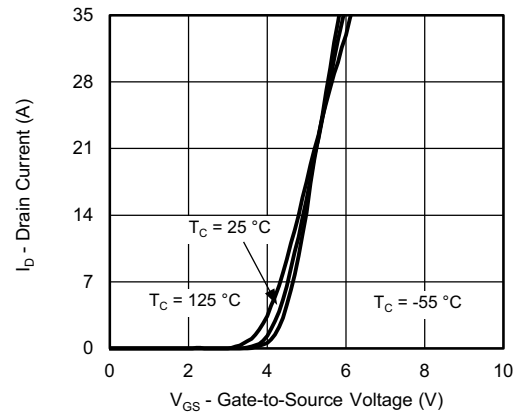
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

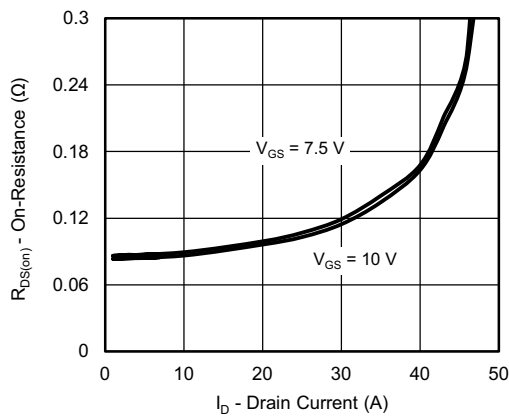
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



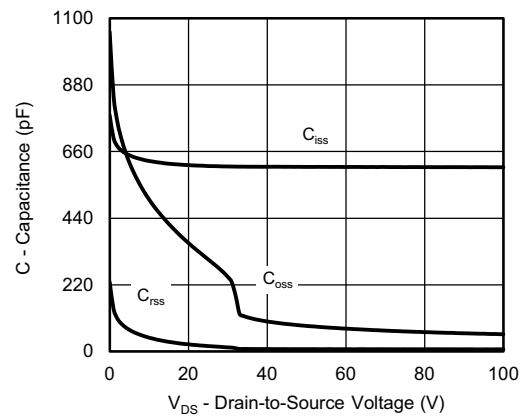
Output Characteristics



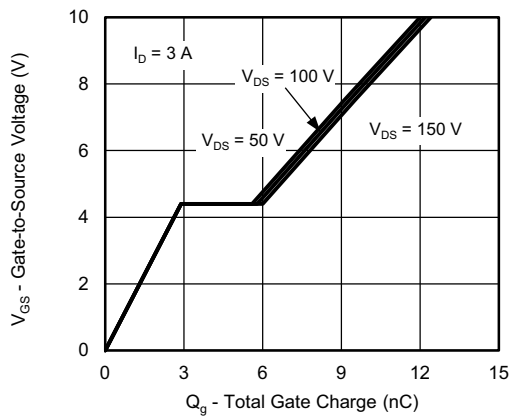
Transfer Characteristics



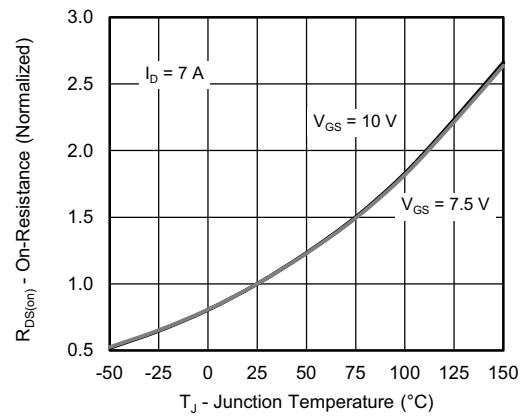
On-Resistance vs. Drain Current



Capacitance

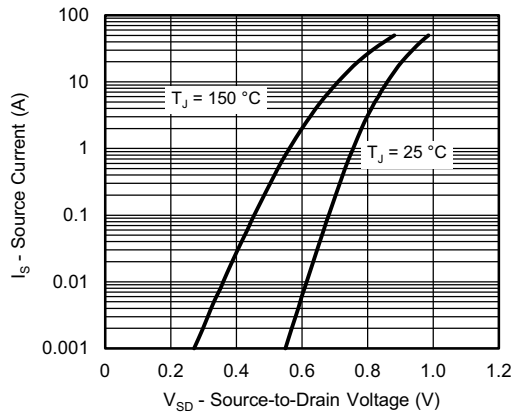


Gate Charge

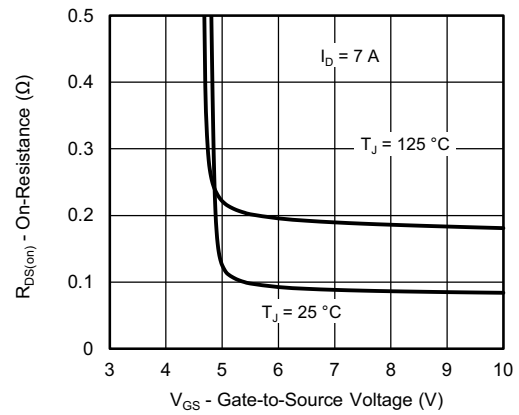


On-Resistance vs. Junction Temperature

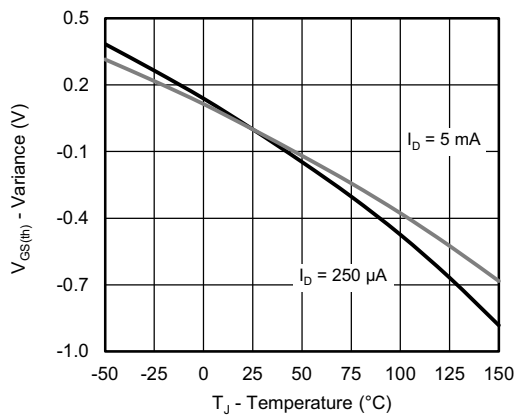
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



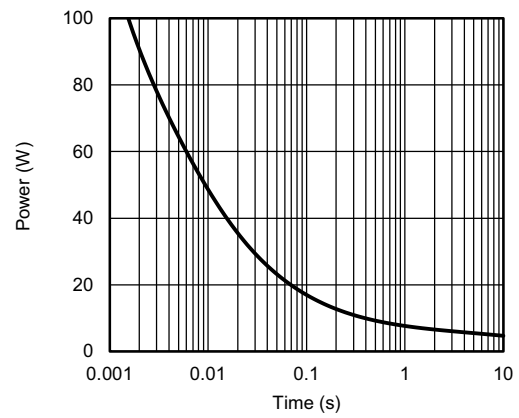
Source-Drain Diode Forward Voltage



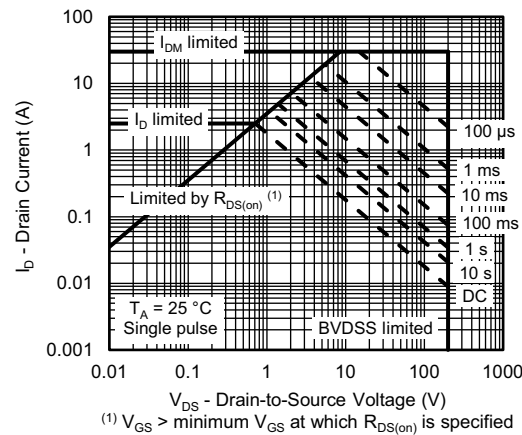
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

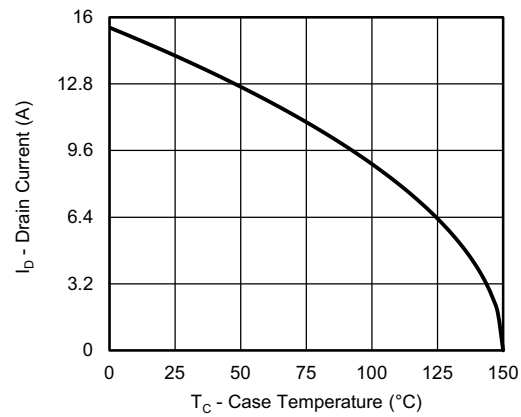
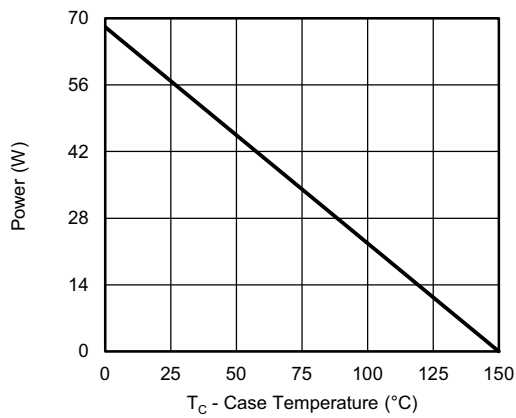
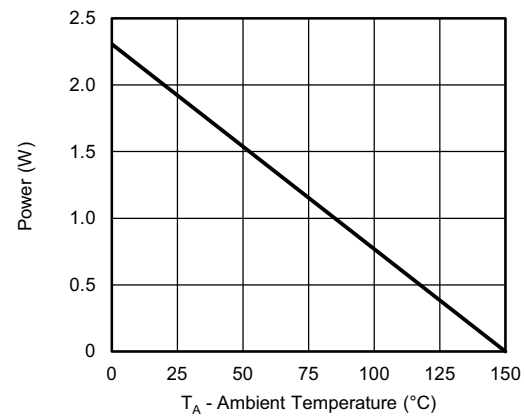


Single Pulse Power, Junction-to-Ambient

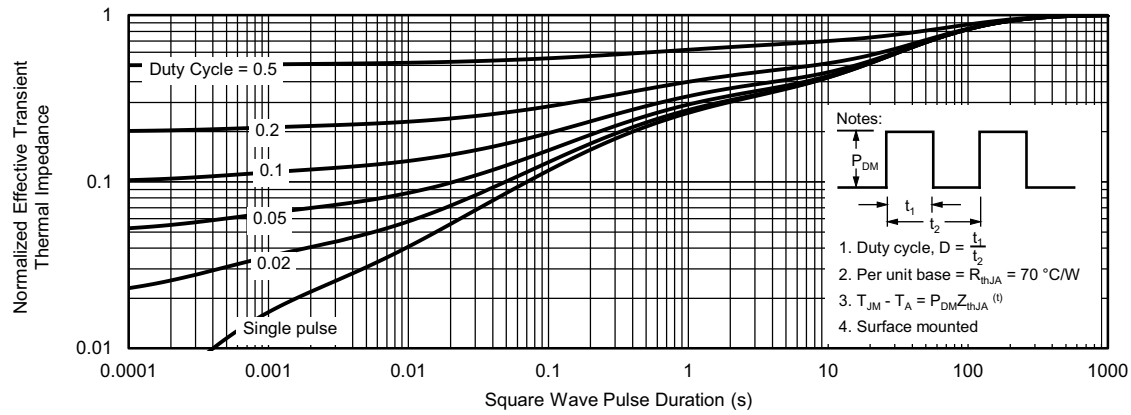
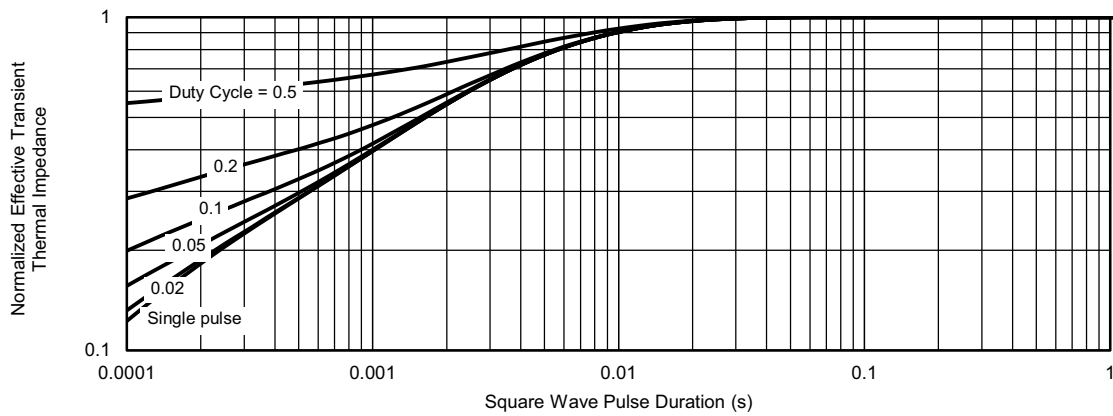


Safe Operating Area

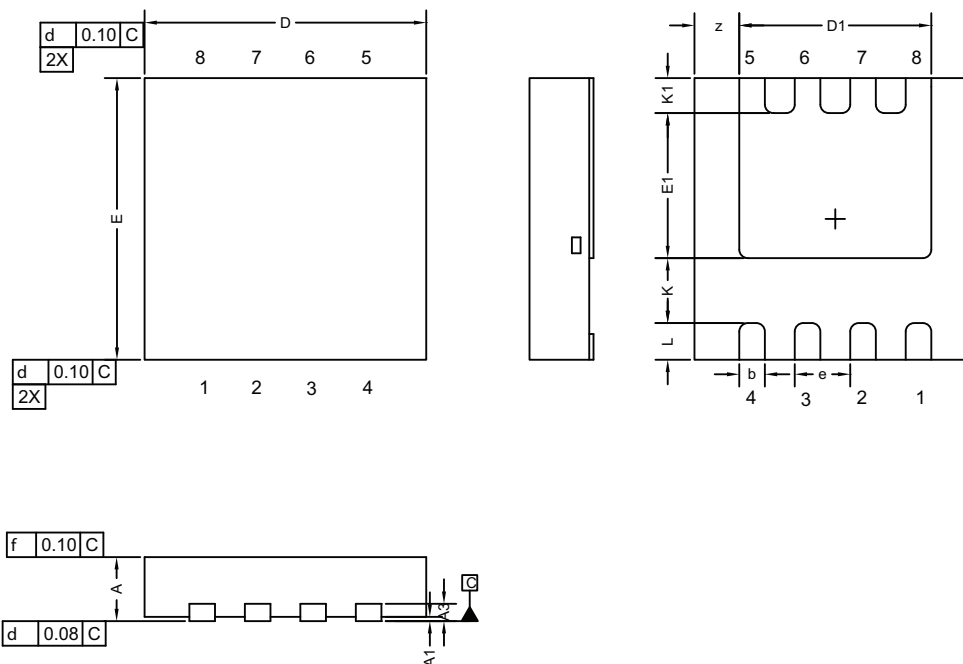
⁽¹⁾ $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)**Current Derating ^a****Power, Junction-to-Case****Power, Junction-to-Ambient****Note**

- a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case

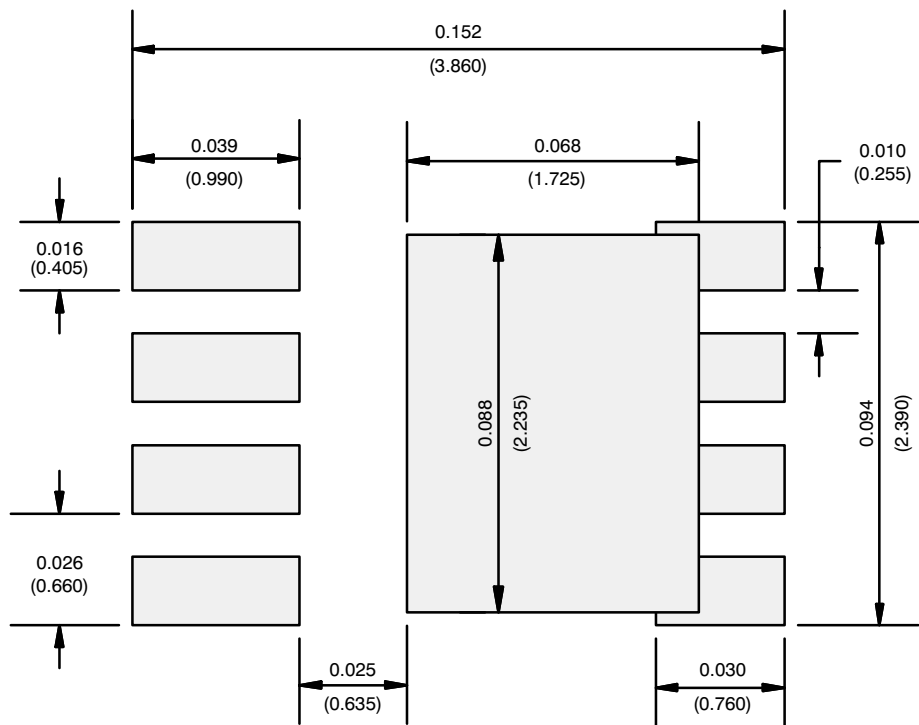
Case Outline for DFN3X3



DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.67	0.75	0.83	0.027	0.030	0.033
A1	0	-	0.05	0	-	0.002
A3	0.20 REF			0.008 REF		
b	0.30 BSC			0.012 BSC		
D	3.30 BSC			0.130 BSC		
D1	2.15	2.25	2.35	0.084	0.088	0.092
E	3.30 BSC			0.130 BSC		
E1	1.60	1.70	1.80	0.063	0.067	0.071
e	0.65 BSC			0.026 BSC		
K	0.76 TYP			0.030 TYP		
K1	0.41 TYP			0.016 TYP		
L	0.43 BSC			0.017 BSC		
z	0.525 TYP			0.021 TYP		
ECN: C12-0200-Rev. A, 12-Mar-12 DWG: 6008						

Note

- Millimeters will govern.



Recommended Minimum Pads
Dimensions in Inches/(mm)

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